



FORM PTO-1449

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P0079.US2Serial No.:
10/628,839OFFICE OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION
DISCLOSURE STATEMENT

Applicant: Robert G. Messerschmidt, et al

Filing Date

Group Art: 2872

July 28, 2003

~~Unknown~~

Sheet 1 of 1

U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Date	Name	Class	Sub Class	Filing Date If Appropriate
AA	1007	5,596,992	01/28/97	Haaland et al	128	664
AB	1007	5,945,674	08/31/99	Dukor	250	339.11
AC		6,421,548 B1	07/16/02	Berman et al	600	322
AD	1057	10/262,692	_____	Jones	436	171 10/02/02

FOREIGN PATENT DOCUMENTS

Document No.	Date	Country	Class	Sub Class	Translation Yes No
		NOVG			

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

CS		The Continual Evolution of the Pap Smear, OB/GYN special edition, vol. 5, 2002, pp 61-64
CT		Skoog, D. A. and Leary, J. J., "Principles of Instrumental Analysis", Fort Worth: Saunders, 1992
CU		Fahrenfort, J., "Attenuated Total Reflection - A new principle for the production of useful infra-red reflection spectra of organic compounds" Spectrochimica Acta, (1961) vol. 17, pp. 608-700. Pergamon Press Ltd.
CV	1057	Harrick, N.J., "Internal Reflection Spectroscopy", Interscience Publishers, Copyright 1967 by John Wiley & Sons, Inc.-Library of Congress Catalog Number 67-13944.
CW		Fringeli, U. P.; Goette, Jeannette; Reiter, Gerald; Siam, Monira; Baurecht, Dieter, "Structural Investigations of Oriented Membrane Assemblies by FTIR-ATR Spectroscopy," Institute of Physical Chemistry, University of Vienna, Althanstrasse 14, A-1090 Vienna, Austria. Medinova AG, Eggbühlstrasse 14, CH-8050 Zurich, Switzerland. DeHaseth, J.A., AIP Conference Proceedings No. 430, 1998, The American Institute of Physics, Woodbury, N.Y.
CX		Haaland, D. M.; Jones, H. D. T.; Thomas, E. V., "Multivariate Classification of Infrared Spectra of Cell and Tissue Samples," Applied Spectroscopy, Vol. 51, Number 3, 1997, pp. 340-345.
CY		Levenson, R. M.; Hoyt, C. C., "Spectral Imaging and Microscopy," American Laboratory, 2000, pp. 1-8.

EXAMINER:

DATE CONSIDERED:

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.